


<b>Search Notes</b>  	<b>Application/Control No.</b>  10599609	<b>Applicant(s)/Patent Under Reexamination</b>  OOHASHI ET AL.
	<b>Examiner</b>  SELIM AHMED	<b>Art Unit</b>  2826

SEARCHED			
Class	Subclass	Date	Examiner
257	292,	12/12/08	/sa/
	Updated search	6/22/2009	/sa/
257	233, 462, e25.032, e33.076, e31.065, e31.125, e31.058, e31.063, e31.115, e25.032, e27.133-e33.139	1/15/2010	/sa/
	Updated search	1/15/2010	/sa/

SEARCH NOTES		
Search Notes	Date	Examiner
Text search such as, (photo or light)/detector, diode, sensor, amplifier, optical fiber, coupler, case/package, scatter, metal, semiconductor, impurity/doping, aperture/opening/hole and their boolean combinations were searched.	12/12/08	/sa/
Updated search	6/22/2009	/sa/
Updated search	1/15/2010	/sa/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	233, 462	1/15/2010	/sa/

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